



SPECIFICATION

Customer:		
		Receipt
Item:	Crystal Unit	
Type:	NX2016SA	
Nominal Frequency:	26.000 MHz	
Customer's Spec. No.:		
NDK Spec. No.:	EXS00A-CS08835	
Charge:		
Sales		
Engineer		

	Revision Record						
Rev.	Date	Items	Contents	Approved	Checked	Drawn	
	27.Mar.2015	Issue		H.Kobayashi	M.Harada	N.Wakisaka	
А	28.May.2015	4.5 Equivalent resistance	Revise : 120Ω Max. →60Ω Max.	H.Kobayashi	K.Komada	N.Wakisaka	
В	4.Jun.2015	4.9 Level of drive	Add : 0.01µW Min.	H.Kobayashi	K.Komada	N.Wakisaka	

1. Customer's Spec. No. :

2. NDK Spec. No. : EXS00A-CS08835

3. Type : NX2016SA

4. Electrical Specifications

	Parameters		Electrical Spec.			C.	Notes	
	Farameters	SYM.	min	typ	max	Units	INULES	
1	Nominal frequency	f_{nom}		26.000		MHz		
2	Overtone order	-	Fu	ndamer	ntal	-		
3	Frequency tolerance	•	-15	ı	+15	ppm	at +25°C	
4	Frequency versus temperature characteristics	-	-50	-	+50	ppm	at -40~+125°C The reference temperature shall be +25°C	
5	Equivalent resistance	-	-	-	60	Ω	IEC π -Network Series	
6	Shunt capacitance	C ₀	-30%	0.61	+30%	pF	Not grounded	
7	Motional capacitance	C ₁	-30%	1.52	+30%	fF	Not grounded	
8	Load capacitance	C _L	ı	8	-	pF	IEC π-Network	
9	Level of drive	-	0.01	10	200	μW		
10	Insulation resistance	-	500	1	-	МΩ	When terminal to terminal and terminal to cover were applied at DC100V ±15V.	
11	Operating temperature range	T_{opr}	-40	ı	+125	°C		
12	Storage temperature range	T_{str}	-40	-	+125	°C		
13	Air-tightness	-	-	-	1.1×10 ⁻⁹	Pa m³/s	Helium leak detector	

5. Examination results document

Since a performance is guaranteed, an examination results document does not submit.

6. Application drawing

6.1 External dimension : EXD14B-00467
6.2 Taping and reel figure : EXK17B-00200
6.3 Holder marking : EXH11B-00319
6.4 Reliability assurance Item : EXS30B-00499
6.5 Recommendation reflow profile : EXS30B-00344

7. Notice

- 7.1 Order items are manufactured according to specification. As to conditions, which are not indicated in this specification and unpredictable such as applied condition and oscillation margin, please check them beforehand.
- 7.2 Unless we receive request for modification within 3 weeks from the issue date of this NDK specification sheet, we will supply products according to this specification. Also, if you'd like to modify specification of order, which has been placed with delivery request within 3 weeks from the issue data of this specification sheet, we would like to discuss with you separately.
- 7.3 In no event shall the company be liable for any product failure resulting from an inappropriate handling or operation of the product beyond the scope of its guarantee.
- 7.4 Where any change to the process condition is made due to the change(s) in the production line, inform personnel of the specifications.
- 7.5 Should this specification data give rise to any disputes relating to any intellectual property rights or any other rights of a third person, the company shall not indemnify anyone for any damage. Their disclosure must not be construed as the grant of a license to use any of the intellectual property rights owned by the company.
- 7.6 If you intend to use products listed on this specification for applications that may result in loss of life or assets (controls relating to safety, medical equipment, aeronautical equipment, space equipment, etc.), please do not fail to advise us of your intention beforehand.
- 7.7 In the company's production process whatever amount of ozone depleting substances (ODS) as specified in the Montreal protocol is not used.
- 7.8 Information contained in this specification must not be quoted, reproduced or used for other purposes including processing either in part or in full without obtaining prior approval from the company.
- 7.9 Crystal units will be damaged by ultrasonic welding process due to resonance of crystal wafer itself. NDK does not recommend using ultrasonic welding. If Ultra Sonic welding used, NDK strongly recommend verifying crystal unit damage by ultrasonic weld.
- 7.10 In case of the product long time keep at high temperature and humidity, may affect product characteristic (solder ability) and a packing condition. Please keep at storage condition of temperature +5°C ~+35°C, humidity ~85%RH.

8. Prohibited items

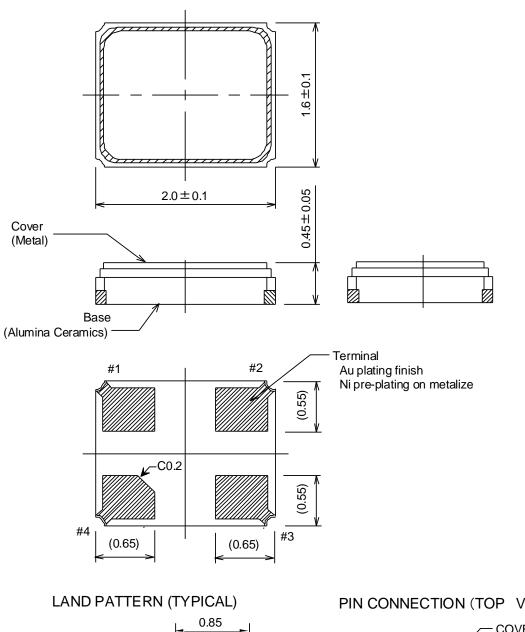
Be sure to use the product under the following conditions. Otherwise, the characteristics deterioration or destruction of the product may result.

(1) Reflow soldering heat resistance

Peak temperature: 265°C, 10 sec Heating: 230°C or higher, 40 sec Preheating: 150°C to 180°C, 120 sec

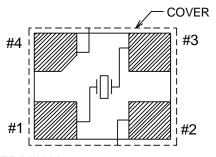
Reflow passage times: twice
(2) Manual soldering heat resistance

Pressing a soldering iron of 400°C on the terminal electrode for four seconds (twice).



0.75 1.35

PIN CONNECTION (TOP VIEW)

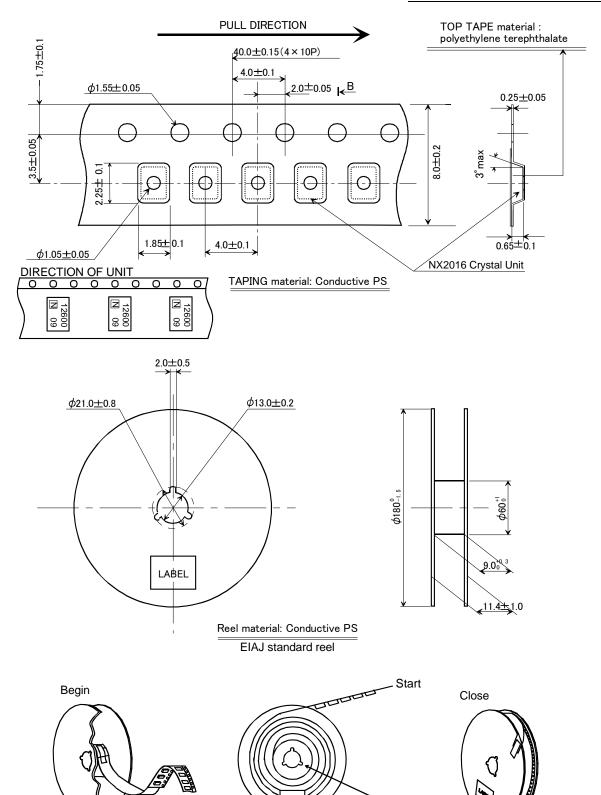


TERMINAL #1,#3 : XTAL

#2,#4 : GND(CONNECTION WITH COVER)

	Dat	e of Revise	Charge	Approved	Reason				
Α	15	.Feb.2011	H.Ouchi	K.Ueki	Index position correction.				
		Date	Name	Third Angle Proje	Third Angle Projection Tolerance		Tolerance	Scale	
Drav	wn	19.Oct.2009	M.Harada	Dimension:m	nm/		'		
Des	signed	19.Oct.2009	M.Harada	Title			Drawing No.		Rev.
Che	ecked			NX2016SA			EXD14B-	00467	Α
App	roved	20.Oct.2009	K.Ueki	Dimension Drawing		ng	EAD 14D	Α	

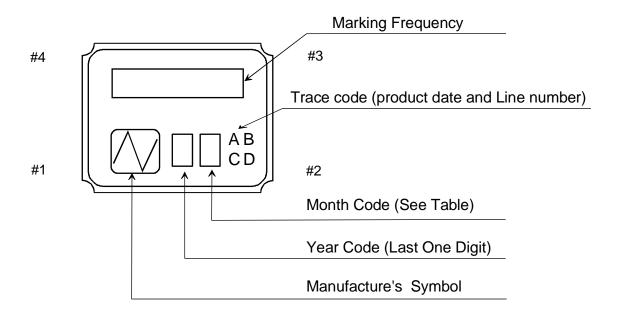
NIHON DEMPA KOGYO CO., LTD.



	Da	te of Revise	Charge	Approved	Reason				
Α	26.No	v.2009	H.Ouchi	K.Ueki	Title chan	ge			
		Date	Name	Third Angle Projection T		Tolerance	Sc	ale	
Dra	wn	12.Apr.2005	K.Oguri	Dimension:mm				/	
Des	signed	12.Apr.2005	K.Oguri	Title	Title			Rev.	
Che	ecked			NX2016 Series		EVV47D	00200	Α	
App	oroved	12.Apr.2005	K. Miyashita	Taping and Reel Spec.		ec. EXKI/D	EXK17B-00200		

3000pcs-Product Tape

End



NOTE

1. Month Code Table

Month	1	2	3	4	5	6	7	8	9	10	11	12
	Jan.	Feb.	Mar.	Apr.	May.	Jun.	Jul.	Aug.	Sep.	Oct.	Nov.	Dec.
Month Code	1	2	3	4	5	6	7	8	9	X	Y	Z

^{*}Marking digits are not include a decimal point and dot mark.

	Dat	te of Revise	Charge	Approved	Reason			
Α	10	. Jul. 2008	T.Asamizu	K.Kubota	Delete app	lication period.		
		Date	Name	Third Angle Projection T		Tolerance	Sc	ale
Drav	wn	14. Feb. 2006	T.Asamizu	Dimension:mm			,	1
Des	signed	14. Feb. 2006	T.Asamizu	Title	Title			Rev.
Che	ecked	14. Feb. 2006	I.Miyahara	Crystal Holder Marking		- EVII44D 00240		Α
App	roved	14. Feb. 2006	K.Okamoto			g EXHIIB	EXH11B-00319	

Reliability assurance item

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No.	Test Item	Test Methods	Specification Code
1	High Temperature Storage	+125±3°C 1000h	A,D
2	Low Temperature Storage	-40±3°C 1000h	A,D
3	Temperature Humidity	+85±3°C 80~85%RH 1000h	A,D
4	Temperature Cycling	-55±5°C / +125±5°C It is 1000 cycles using 30 minutes each as 1 cycle.	A,D
5	Vibration	Frequency Range: 10~2000Hz Amplitude or Acceleration: 1.52mm or 196m/s² 1 cycle: 20 minutes Test time: Three mutually perpendicular axes each 4 hours.	B,D
6	Shock	Devices are shocked to half sine wave (49000m/s ² , 0.15msec) six mutually perpendicular axis each 1 times.	B,D
7	Drop	Devices are dropped from the height 75cm onto iron plate. Execution 3 times random drops.	B,D
8	Solderability	Pre-heat temperature: +150±10°C Pre-heat time: 60~120s When the temperature of the specimen is reached at +215±3°C, it shall be left for 30±1sec. Material: H63A (Silver 2~3%) Flux: Rosin resin methyl alcohol solvent (1:4)	С
9	Reflow resistance	Pre-heat temperature: +150~180°C Pre-heat time: 90±30s Heat temperature: more than +230°C Pre-heat time: less than 30s Peak temperature: +260±5°C Peak time: less than 10s	B,D

Specification code	Specification
А	$\Delta f/f \le \pm 20$ ppm $\Delta CI/CI \le \pm 15$ % or 5 Ω make use larger value
В	$\Delta f/f \le \pm 10$ ppm $\Delta CI/CI \le \pm 15$ % or 5 Ω make use larger value
С	The electrodes should be covered by a new solder at least 90% of immersed area.
D	After testing unless cracking of materials view of eyes and unless break of seal.

Recommendation reflow condition

1.IR reflow condition

